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| Notice of References Cited | Application/Control No. 09/853,323 | Applicant(s)/Patent Under Reexamination HOSHIDA ET AL. | |
| | Examiner Chau M Nguyen | Art Unit 2633 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,310,709 B1 | 10-2001 | Bergano, Neal S. | 398/185 |
| | B | US-6,417,958 B1 | 07-2002 | Du et al. | 359/334 |
| | C | US-6,366,376 B1 | 04-2002 | Miyata et al. | 398/79 |
| | D | US-6,496,297 B1 | 12-2002 | Frankel et al. | 359/279 |
| | E | US-6,735,395 B1 | 05-2004 | Bai, Yu Sheng | 398/95 |
| | F | US-6,381,048 B1 | 04-2002 | Chraplyvy et al. | 398/79 |
| | G | US-6,556,326 B2 | 04-2003 | Bergano, Neal S. | 398/183 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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